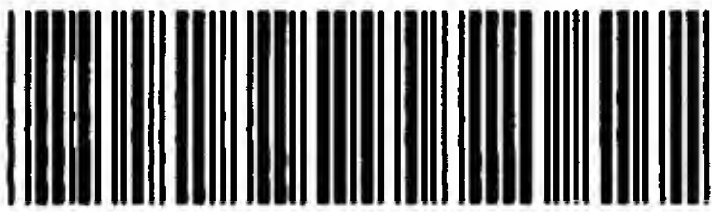


<b>Search Notes</b>  	<b>Application/Control No.</b>  10708730	<b>Applicant(s)/Patent Under Reexamination</b>  HO ET AL.
	<b>Examiner</b>  Detschel, Marissa J	<b>Art Unit</b>  2877

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
356	328, 334	12/8/06	MJD

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Updated EAST search from 5/5/06	12/8/06	MJD
Consulted Fannie Evans on allowable subject matter	1/11/07	MJD
Search terms: curved, concave, grating, path difference, arc length, groove, distance, position, slit, detector	1/4/07	MJD
Search Updated	6/07/2007	JC
Consulted Fannie Evans and Kara Geisel on allowable subject matter	6/07/2007	JC

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
Interference searched	Searched above class/subclasses	6/07/2007	JC